FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Rev. 2-32) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary) APPLICANT(S) Kenichiro Kobayashi et al. FILING DATE GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER								DATE .	NAME	CLASS	SUB- CLASS	FILING DATE IF APPRO- PRIATE	
X'S		5	3	4	3	2	8	7	08/30/1994	Wilkins				
1		4	6	2	1	0	6	3	11/04/1986	Wyatt et al.				
		4	7	9	4	3	8	4	12/27/1988	Jackson				
XS		5	6	3	3	7	1	4	05/27/1997	Nyyssonen				

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL			D	OCUM	ENT I	NUMB	ER		DATE	COUNTRY	CLASS	SUB- CLASS		NSLA- ION
													Υ	N
1/8	DE	19	7	3	9	6	79	Al	10/1998	Germany		->		
		2	7	0	1	7	6	2	08/1994	France				
	DE	19	8	1	7	6	64	Al	11/1999	Germany				
	DE	19	9	0	9	2	35	Al	09/1999	Germany		<u> </u>		
7.5	DE	19	6	2	0	4	19	Al	11/1997	Germany				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL	
RS	U.S. Patent Application Publication 2002/0080264, publication date June 27, 2002 entitled METHOD AND APPARATUS FOR DIRECT IMAGE PICK-UP OF GRANULAR SPECK PATTERN GENERATED BY REFLECTING LIGHT OF LASER BEAM

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